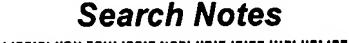


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/721,931	BARTH ET AL.	
	Examiner Alex Liew	Art Unit 2624	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner